

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/881,024	BHASKARAN ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Mark P. Francis	2193	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,199,195 B1	03-2001	Goodwin et al.	717/104
*	B	US-6,442,748 B1	08-2002	Bowman-Amuah, Michel K.	717/108
*	C	US-2002/0129345 A1	09-2002	Tilden et al.	717/162
*	D	US-2002/0157004 A1	10-2002	Smith et al.	713/176
*	E	US-2002/0169658 A1	11-2002	Adler, Richard M.	705/10
*	F	US-6,601,234 B1	07-2003	Bowman-Amuah, Michel K.	717/108
*	G	US-6,618,852 B1	09-2003	van Eikeren et al.	717/108
*	H	US-6,662,355 B1	12-2003	Caswell et al.	717/103
*	I	US-2004/0083463 A1	04-2004	Hawley, David	717/140
*	J	US-6,789,252 B1	09-2004	Burke et al.	717/100
*	K	US-2005/0149489 A1	07-2005	Abjanic et al.	707/001
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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